

Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/666,206	BISWAS ET AL.
Examiner	Art Unit	
Naheed Ejaz	2611	

ISSUE CLASSIFICATION

ORIGINAL			CROSS REFERENCE(S)					
CLASS		SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
375		264	375	286	316	340		
INTERNATIONAL CLASSIFICATION								
H	0	4	L	5/12				
				/				
				/				
				/				
				/				
<i>Ejaz Naheed</i> Naheed Ejaz (02/07/2008) (Assistant Examiner) (Date)						<i>Chieh M. Fan</i> Chieh M. Fan (Primary Examiner) (Date) <i>3/13/08</i>		
						O.G. Print Claim(s)	O.G. Print Fig.	
						1	3	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		61		91
2	2		32		62		92
3	3		33		63		93
4	4		34		64		94
5	5		35		65		95
6	6		36		66		96
7	7		37		67		97
8	8		38		68		98
9	9		39		69		99
10	10		40		70		100
11	11		41		71		101
12			42		72		102
12	13		43		73		103
13	14		44		74		104
14	15		45		75		105
15	16		46		76		106
17			47		77		107
16	18		48		78		108
17	19		49		79		109
18	20		50		80		110
21			51		81		111
22			52		82		112
23			53		83		113
24			54		84		114
25			55		85		115
26			56		86		116
27			57		87		117
28			58		88		118
29			59		89		119
30			60		90		120